

### FEATURES

- Input voltage range: 6 V to 60 V
- On-board 5 V low dropout regulator
- Selective buck or boost mode
- Excellent PWM linearity with high amplitude PWM sawtooth 4.0 V p-p
- FAULT input compatible with AD8450
- COMP input compatible with AD8450
- Adjustable frequency from 50 kHz to 300 kHz
- Synchronization output or input with adjustable phase shift
- Programmable maximum duty cycle
- Maximum internal duty cycle: 98%
- Programmable soft start
- Peak hiccup current limit protection
- Input voltage UVLO protection
- TSD protection
- 16-lead TSSOP

### APPLICATIONS

- PWM battery test systems with recycle capability including hybrid vehicles, PCs, and camera batteries
- Compatible with AD8450 constant voltage (CV) and constant current (CC) monitors

### GENERAL DESCRIPTION

The ADP1972 is a constant frequency, voltage mode, pulse-width modulation (PWM) controller for buck or boost, dc-to-dc, asynchronous applications. The ADP1972 is designed for use in asynchronous battery testing applications with an external, high voltage field effect transistor (FET), half bridge driver, and an external control device, such as the AD8450. The asynchronous device operates as a buck converter in battery charge mode and operates as a boost converter in recycle mode to recycle energy to the input bus.

The ADP1972 high voltage, VIN supply pin can withstand a maximum operating voltage of 60 V and reduces the need for additional system supply voltages. The ADP1972 has integrated features such as precision enable, pin selective buck or boost mode operation, internal and external synchronization control with programmable phase shift, programmable maximum duty cycle, and programmable peak hiccup current limit. Additional protection features include soft start to limit input inrush current during startup, input voltage undervoltage lockout (UVLO), and thermal shutdown (TSD). The ADP1972 also has a COMP pin to provide external control of the PWM operation and a FAULT pin that can be signaled to disable the DH and DL outputs if a fault condition occurs externally to the ADP1972.

The ADP1972 is available in a 16-lead TSSOP package.

### TYPICAL APPLICATION CIRCUIT

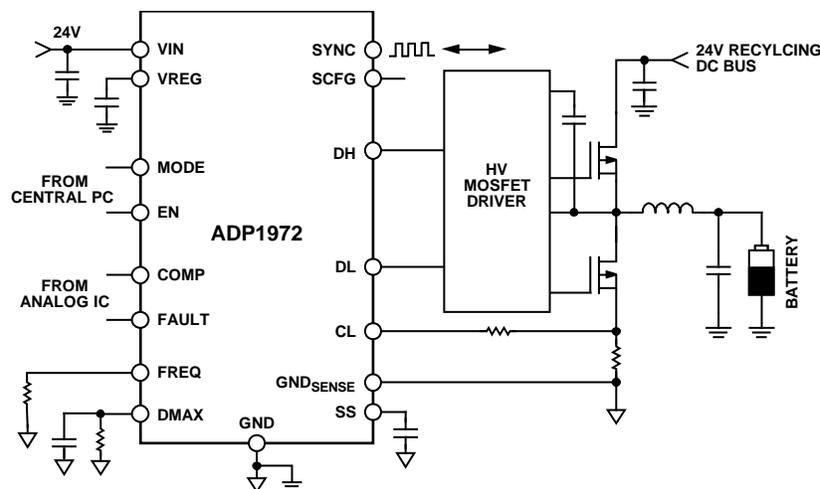


Figure 1.

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## REVISION HISTORY

1/14—Revision 0: Initial Version

## SPECIFICATIONS

V<sub>IN</sub> = 24 V and the specifications are valid for T<sub>J</sub> = -40°C to +125°C, unless otherwise specified. Typical values are at T<sub>A</sub> = 25°C. All limits at temperature extremes are guaranteed via correlation using standard statistical quality control (SQC).

Table 1.

Parameter	Symbol	Test Conditions/Comments	Min	Typ	Max	Unit
<b>INPUT VOLTAGE (VIN)</b>						
Voltage Range	V <sub>IN</sub>		6		60	V
VIN Supply Current	I <sub>VIN</sub>	R <sub>FREQ</sub> = 100 kΩ, V <sub>SS</sub> = 0 V, SYNC floating		1.5	2.5	mA
VIN Shutdown Current	I <sub>SHDN</sub>	V <sub>EN</sub> = 0 V		15	70	μA
UVLO Threshold Rising		V <sub>IN</sub> rising		5.71	6	V
UVLO Threshold Falling		V <sub>IN</sub> falling	5.1	5.34		V
<b>SOFT START (SS)</b>						
SS Pin Current	I <sub>SS</sub>	V <sub>SS</sub> = 0 V	4	5	6	μA
SS Threshold Rising				0.52	0.65	V
SS Threshold Falling			0.4	0.5		V
<b>PWM CONTROL</b>						
<b>FREQ</b>						
Frequency Range	f <sub>SET</sub>		50		300	kHz
Oscillator Frequency	f <sub>OSC</sub>	R <sub>FREQ</sub> = 100 kΩ	90	100	110	kHz
FREQ Pin Voltage	V <sub>FREQ</sub>	R <sub>FREQ</sub> = 100 kΩ	1.2	1.252	1.3	V
<b>SYNC</b>						
Maximum SYNC Pin Voltage					5.5	V
SYNC Pull-Down Resistor			0.5	1	1.5	MΩ
<b>SYNC Output (Internal Frequency Control)</b>						
Internal SYNC Range	f <sub>SET</sub>	V <sub>SCFG</sub> ≥ 4.53 V or SCFG pin floating For SYNC output	50		300	kHz
SYNC Output Clock Duty Cycle		V <sub>SCFG</sub> = V <sub>VREG</sub> , R <sub>FREQ</sub> = 100 kΩ	40	50	60	%
SYNC Sink Resistance	R <sub>SYNC</sub>	V <sub>SCFG</sub> = 5 V, I <sub>SYNC</sub> = 10 mA		10	20	Ω
<b>SYNC Input (External Frequency Control)</b>						
External SYNC Range	f <sub>SYNC</sub>	V <sub>SCFG</sub> < 4.25 V For SYNC input clock	50		300	kHz
SYNC Threshold Rising				1.2	1.5	V
SYNC Threshold Falling			0.7	1.05		V
R <sub>FREQ</sub> Slave to Master Ratio for Synchronization		For example, R <sub>FREQ (SLAVE)</sub> = 1.11 × R <sub>FREQ (MASTER)</sub>		1.11		
<b>SCFG</b>						
SCFG High Threshold Rising				4.53	4.7	V
SCFG High Threshold Falling			4.25	4.51		V
SCFG Low Threshold Rising				0.52	0.65	V
SCFG Low Threshold Falling			0.4	0.5		V
SCFG Current	I <sub>SCFG</sub>	R <sub>FREQ</sub> = 100 kΩ	9.5	11	12.5	μA
<b>DMAX</b>						
Maximum Internal Duty Cycle		V <sub>COMP</sub> , V <sub>DMAX</sub> , V <sub>SS</sub> , and V <sub>SCFG</sub> = 5 V		97.37		%
DMAX Setting Current	I <sub>DMAX</sub>	V <sub>DMAX</sub> = 0 V, R <sub>FREQ</sub> = 100 kΩ	9.5	11	12.5	μA
DMAX and SCFG Current Matching <sup>1</sup>					10	%
<b>COMP</b>						
Maximum COMP Pin Voltage	V <sub>COMP</sub>				5	V
Internal Peak-to-Peak Ramp Voltage	V <sub>p-p</sub>			4		V
COMP Maximum Internal Ramp Voltage				4.5		V
COMP Minimum Internal Ramp Voltage		Internal oscillator is disabled	0.45	0.5	0.55	V
DH and DL Shutdown Range <sup>2</sup>	V <sub>COMP</sub>	COMP not regulated			0.45	V
Maximum Duty Cycle Range <sup>2</sup>	V <sub>COMP</sub>			4.4	5	V

Parameter	Symbol	Test Conditions/Comments	Min	Typ	Max	Unit
PRECISION ENABLE LOGIC (EN)						
Maximum EN Pin Voltage					60	V
EN Threshold Rising				1.25	1.4	V
EN Threshold Falling			1.1	1.22		mV
EN Pin Current		$V_{EN} = 5V$		0.32	2	$\mu A$
MODE LOGIC						
Maximum MODE Pin Voltage					5.5	V
MODE Threshold Rising				1.20	1.5	V
MODE Threshold Falling			0.7	1.05		V
CURRENT LIMIT (CL)						
Set Current	$I_{CL}$	$V_{CL} = 0V$	18	20	21	$\mu A$
Buck Internal Reference	$V_{REF (BUCK)}$		250	300	350	mV
Boost Internal Reference	$V_{REF (BOOST)}$		450	500	550	mV
Hiccup Detect Time		$R_{FREQ} = 100 k\Omega$	4.4	5.2	6.1	ms
Hiccup Off-Time		$R_{FREQ} = 100 k\Omega$	4.4	5.2	6.1	ms
VREG						
LDO Regulator Output Voltage	$V_{VREG}$	$V_{IN} = 6V \text{ to } 60V$	4.9	5	5.1	V
Guaranteed Output Current	$I_{OUT (MAX)}$	$V_{IN} = 6V$			5	mA
Line Regulation		$V_{IN} = 6V \text{ to } 60V$		5	5.1	V
Load Regulation		$V_{IN} = 6V, I_{OUT} = 0 \text{ mA to } 5 \text{ mA}$		5	5.1	V
FAULT						
Maximum FAULT Pin Voltage					60	V
FAULT Threshold Rising				1.2	1.5	V
FAULT Threshold Falling			0.7	1.05		V
FAULT Pin Current		$V_{FAULT} = 5V$		0.49	2	$\mu A$
PWM DRIVE LOGIC SIGNALS (DH/DL)						
DL Drive Voltage	$V_{DL}$	No load		VREG		V
DH Drive Voltage	$V_{DH}$	No load		VREG		V
DL and DH Sink Resistance		$I_{DL} = 10 \text{ mA}$		1.2	2.4	$\Omega$
DL and DH Source Resistance		$I_{DL} = 10 \text{ mA}$		1.4	2.6	$\Omega$
DL and DH Pull-Down Resistor			0.5	1	1.5	M $\Omega$
THERMAL SHUTDOWN (TSD)						
TSD Threshold Rising				150		$^{\circ}C$
TSD Threshold Falling				135		$^{\circ}C$

<sup>1</sup> The DMAX and SCFG current matching specification is calculated by taking the absolute value of the difference between the measured  $I_{SCFG}$  and  $I_{DMAX}$  currents, dividing them by the 11  $\mu A$  typical value, and multiplying this answer by 100.

$$DMAX \text{ and SCFG Current Matching (\%)} = \left[ \frac{I_{SCFG} - I_{DMAX}}{11 \mu A} \right] \times 100$$

<sup>2</sup> See Figure 11 for a graph of the duty cycle vs. the applied COMP pin voltage.

## ABSOLUTE MAXIMUM RATINGS

Table 2.

Parameter	Rating
VIN, EN, FAULT to GND	−0.3 V to +61 V
SYNC, COMP, MODE to GND	−0.3 V to +5.5 V
DH, DL, SS, DMAX, SCFG, CL to GND	−0.3 V to VREG + 0.3 V
GND <sub>SENSE</sub> to GND	−0.3 V to +0.3 V
Operating Ambient Temperature Range	−40°C to +85°C
Junction Temperature	125°C
Storage Temperature Range	−65°C to +150°C

Stresses at or above those listed under Absolute Maximum Ratings may cause permanent damage to the product. This is a stress rating only; functional operation of the product at these or any other conditions above those indicated in the operational section of this specification is not implied. Operation beyond the maximum operating conditions for extended periods may affect product reliability.

Absolute maximum ratings apply individually only, not in combination.

### THERMAL OPERATING RANGES

The ADP1972 can be damaged when the junction temperature limits are exceeded. The maximum operating junction temperature ( $T_{J\text{ MAX}}$ ) takes precedence over the maximum operating ambient temperature ( $T_{A\text{ MAX}}$ ). Monitoring ambient temperature does not guarantee that the junction temperature ( $T_J$ ) is within the specified temperature limits.

In applications with high power dissipation and poor printed circuit board (PCB) thermal resistance, the maximum ambient temperature may need to be derated. In applications with moderate power dissipation and low PCB thermal resistance, the maximum ambient temperature can exceed the maximum limit when the junction temperature is within specification limits.

The junction temperature ( $T_J$ ) of the device is dependent on the ambient temperature ( $T_A$ ), the power dissipation of the device ( $P_D$ ), and the junction to ambient thermal resistance of the package ( $\theta_{JA}$ ). Use the following equation to calculate the maximum junction temperature ( $T_J$ ) from the ambient temperature ( $T_A$ ) and power dissipation ( $P_D$ ):

$$T_J = T_A + (P_D \times \theta_{JA}) \quad (1)$$

For additional information on thermal resistance, refer to [Application Note AN-000, Thermal Characteristics of IC Assembly](#).

### ESD CAUTION



**ESD (electrostatic discharge) sensitive device.** Charged devices and circuit boards can discharge without detection. Although this product features patented or proprietary protection circuitry, damage may occur on devices subjected to high energy ESD. Therefore, proper ESD precautions should be taken to avoid performance degradation or loss of functionality.

## PIN CONFIGURATION AND FUNCTION DESCRIPTIONS

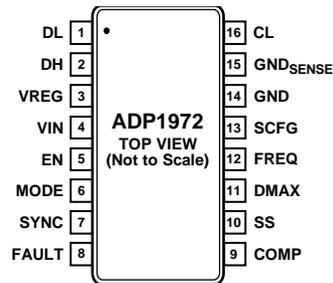


Figure 2. Pin Configuration

Table 3. Pin Function Descriptions

Pin No.	Mnemonic	Description
1	DL	Logic Drive Low Output for External Low-Side MOSFET Driver.
2	DH	Logic Drive High Output for External High-Side MOSFET Driver.
3	VREG	Internal Low Dropout (LDO) Voltage Regulator Output and Internal Bias Supply. A bypass capacitance of 1 $\mu\text{F}$ or greater from this pin to ground is required.
4	VIN	High Input Voltage Supply Pin. Bypass this pin with a 4.7 $\mu\text{F}$ capacitor to ground.
5	EN	Logic Enable Input. Drive EN logic low to shut down the device. Drive EN logic high to turn on the device.
6	MODE	Mode Select. Drive MODE logic low to place the device in boost/recycle mode. Drive MODE logic high to place the device in buck/charge mode of operation.
7	SYNC	Synchronization Pin. This pin is used as an input and synchronized to an external clock or used as an output clock to synchronize with other channels.
8	FAULT	Fault Input Pin. Signaled by an overcurrent protection (OCP) or overvoltage protection (OVP) fault condition on the companion ASIC, <a href="#">AD8450</a> . The <a href="#">ADP1972</a> is disabled until this pin is logic high.
9	COMP	Output Error Amplifier Signal from the companion ASIC, <a href="#">AD8450</a> . This pin is the error input to the <a href="#">ADP1972</a> and is compared internally to the linear ramp to produce the PWM signal. Do not leave this pin floating.
10	SS	Soft Start Control Pin. A capacitor connected from SS to ground brings the output up slowly during power-up and reduces the inrush current.
11	DMAX	Maximum Duty Cycle Input. Connect an external resistor to ground to set the maximum duty cycle. If the 98% internal maximum duty cycle is sufficient for the application, tie this pin to VREG. If DMAX is left floating, this pin is internally tied to VREG.
12	FREQ	Frequency Set Pin. Connect an external resistor between this pin and ground to set the frequency between 50 kHz and 300 kHz.
13	SCFG	Synchronization Configuration Input. Drive $V_{\text{SCFG}} \geq 4.53 \text{ V}$ to configure SYNC as an output clock signal. Drive $V_{\text{SCFG}} < 4.25 \text{ V}$ to configure SYNC as an input. Connect a resistor to ground with $0.65 \text{ V} < V_{\text{SCFG}} < 4.25 \text{ V}$ to introduce a phase shift to the synchronized clock. Drive $V_{\text{SCFG}} \leq 0.5 \text{ V}$ to configure SYNC as an input with no phase shift so that it synchronizes the device to an external clock source. If SCFG is left floating, the SYNC pin is internally tied to VREG, and SYNC is configured as an output.
14	GND	Power and Analog Ground Pin.
15	GND <sub>SENSE</sub>	Ground Sense for the Current-Limit Setting Resistor.
16	CL	Current-Limit Programming Pin. Connect a current-limit sense resistor in series with the FET source to set the peak current limit.

# TYPICAL PERFORMANCE CHARACTERISTICS

$V_{IN} = V_{EN} = V_{FAULT} = 24\text{ V}$ ,  $V_{MODE} = V_{CL} = V_{SS} = V_{COMP} = 0\text{ V}$ ,  $T_A = 25^\circ\text{C}$ , unless otherwise noted.

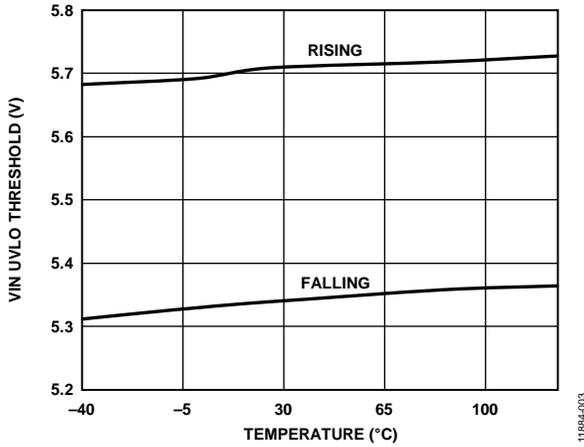


Figure 3. Input Voltage UVLO Threshold vs. Temperature,  $V_{FAULT} = 0\text{ V}$

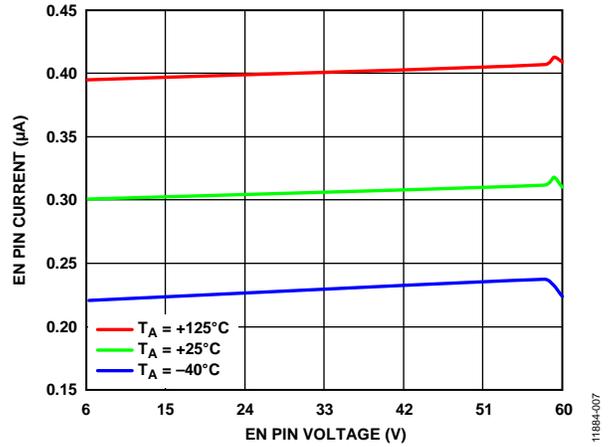


Figure 6. EN Pin Current vs. EN Pin Voltage,  $V_{EN} = 5\text{ V}$  and  $V_{FAULT} = 0\text{ V}$

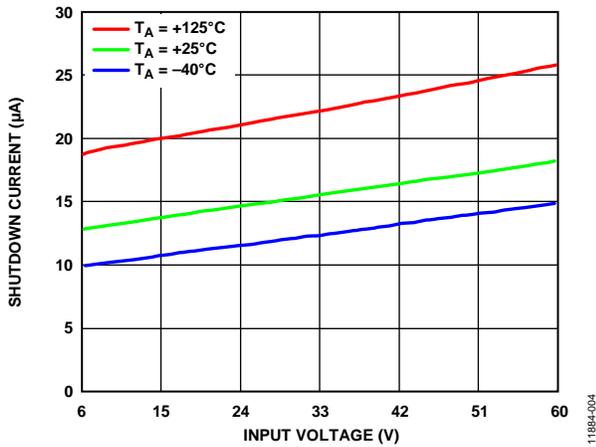


Figure 4. Shutdown Current vs. Input Voltage,  $V_{EN} = 0\text{ V}$  and  $V_{FAULT} = 0\text{ V}$

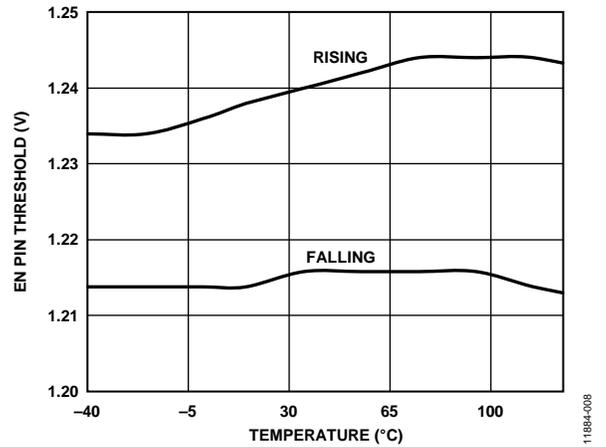


Figure 7. EN Pin Threshold vs. Temperature,  $V_{FAULT} = 0\text{ V}$

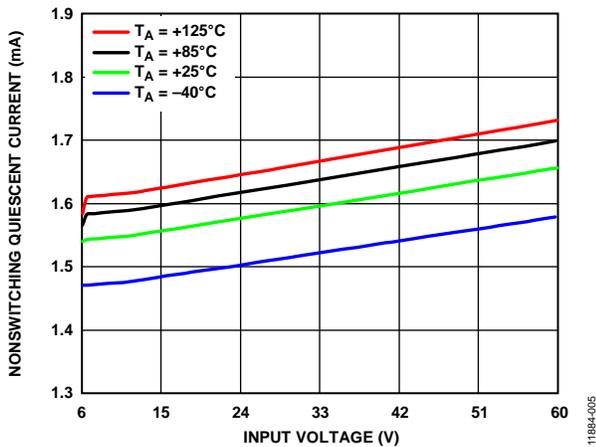


Figure 5. Nonswitching Quiescent Current vs. Input Voltage (SYNC = Floating)

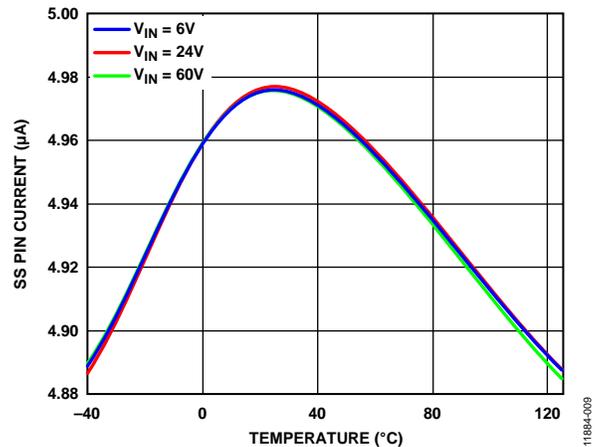


Figure 8. SS Pin Current vs. Temperature

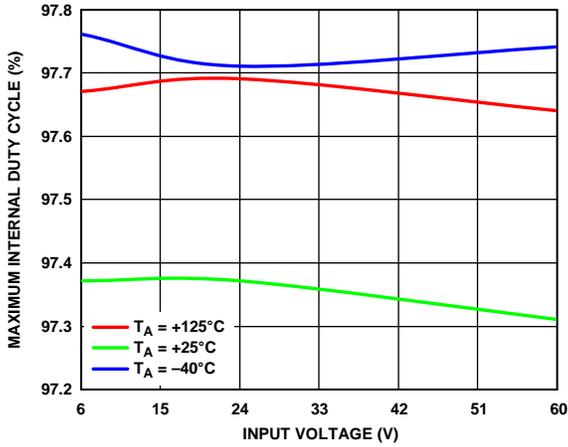


Figure 9. Maximum Internal Duty Cycle vs. Input Voltage,  $R_{FREQ} = 100\text{ k}\Omega$ ,  $V_{COMP} = 5\text{ V}$ , and No Load on DL, DH, or DMAX

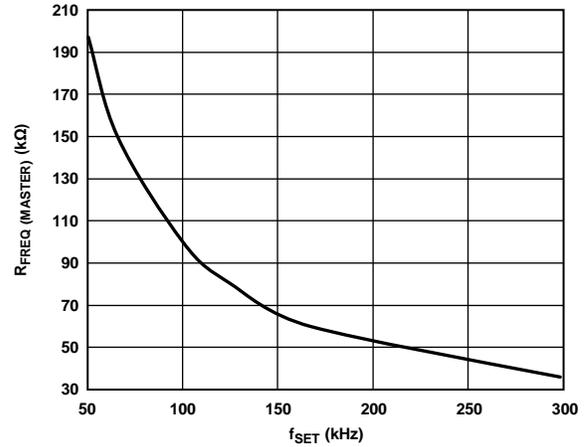


Figure 12.  $R_{FREQ(MASTER)}$  vs. Switching Frequency ( $f_{SET}$ )

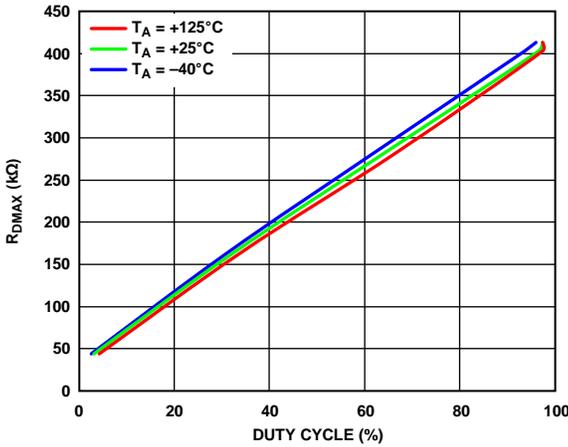


Figure 10.  $R_{DMAX}$  vs. Duty Cycle,  $R_{FREQ} = 100\text{ k}\Omega$ ,  $V_{COMP} = 5\text{ V}$ , and No Load on DL or DH

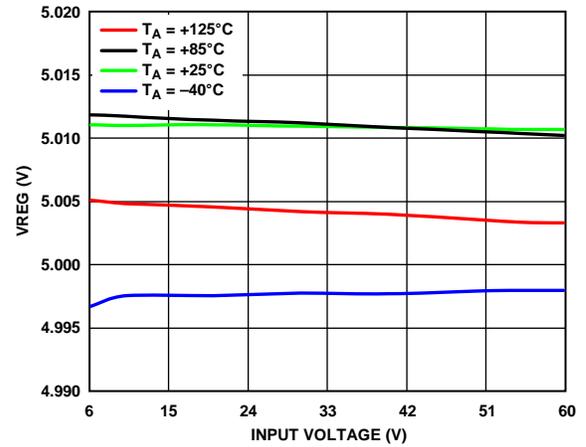


Figure 13.  $V_{REG}$  vs. Input Voltage, No Load

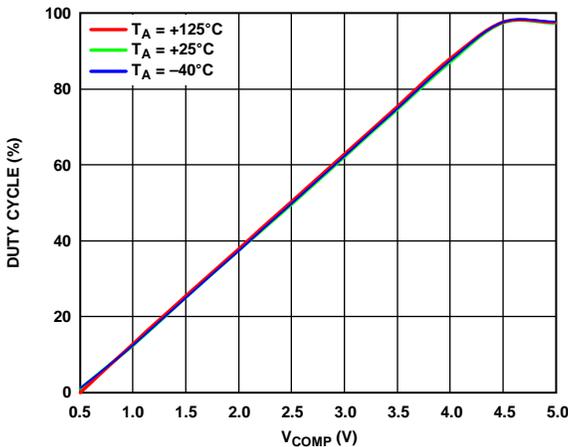


Figure 11. Duty Cycle vs.  $V_{COMP}$ ,  $R_{FREQ} = 100\text{ k}\Omega$ , and No Load on DL, DH, or DMAX

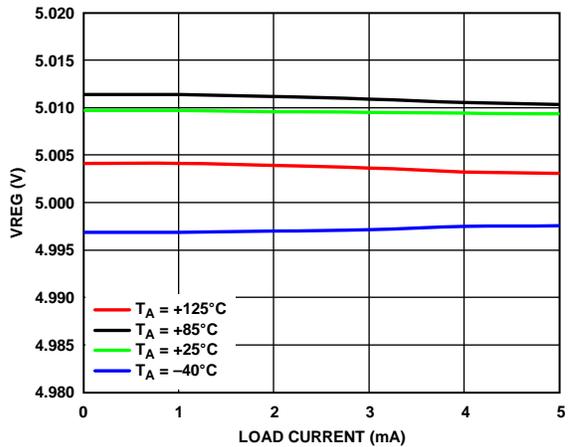


Figure 14.  $V_{REG}$  vs. Load Current

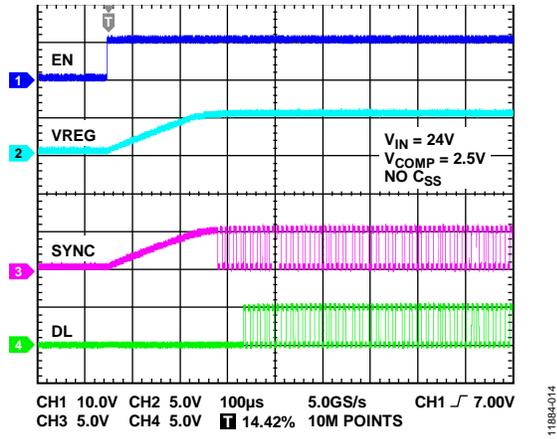


Figure 15. Startup



### EN/SHUTDOWN

The EN input turns the ADP1972 on or off. The EN pin of the ADP1972 can operate from voltages up to 60 V and is designed with stable  $\pm 20\%$  thresholds for precision enable control. When the EN voltage is less than 1.22 V (typical), the ADP1972 shuts down, driving both DL and DH low. When the ADP1972 is shut down, the VIN supply current is 15  $\mu\text{A}$  (typical). When the EN voltage is greater than 1.25 V (typical), the ADP1972 is enabled.

The device can be disabled via the EN pin, a fault condition indicated by a TSD event, a UVLO condition, or an external fault condition signaled via the FAULT pin.

### UNDERVOLTAGE LOCKOUT (UVLO)

There is internal UVLO for the VIN pin. When VIN rises, the UVLO does not allow the ADP1972 to turn on unless VIN is greater than 5.71 V (typical). When VIN falls, the UVLO disables the device when VIN drops below 5.34 V (typical). The UVLO prevents potentially erratic operation of the application at low input voltages that may damage the ADP1972 and the external circuitry. The UVLO levels have  $\sim 370$  mV of hysteresis to ensure glitch free startup.

### SOFT START

The ADP1972 is equipped with a programmable soft start that prevents output voltage overshoot during startup. When the ADP1972 is enabled with the EN pin, the VREG voltage begins rising to 5 V. When VREG reaches 90% of its 5 V (typical) value, the 5  $\mu\text{A}$  (typical) internal soft start current ( $I_{SS}$ ) begins charging the soft start capacitor ( $C_{SS}$ ), causing the voltage on the SS pin ( $V_{SS}$ ) to rise. While  $V_{SS}$  is less than 0.52 V (typical), the ADP1972 switching control remains disabled.

When  $V_{SS}$  reaches 0.52 V (typical), switching is enabled, and regulation of the ADP1972 control loop begins. As  $C_{SS}$  continues to charge and  $V_{SS}$  rises, the PWM duty cycle gradually increases, allowing the output voltage to rise linearly with little to no overshoot during startup.  $C_{SS}$  charges and  $V_{SS}$  rises until  $V_{SS}$  reaches the internal VREG voltage (5 V typical). When the internal system duty cycle is less than the soft start duty cycle, the internal control loop takes control of the ADP1972. See Figure 18 for a soft start diagram.

There is an active, internal, pull-down resistor on the SS pin that discharges  $C_{SS}$  when the device shuts down to prevent a fault from occurring.

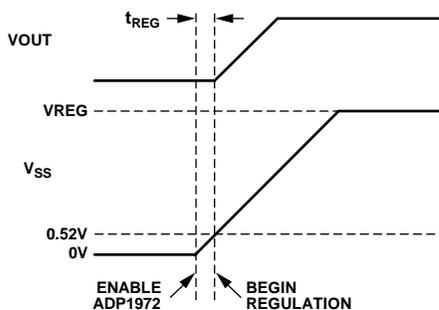


Figure 18. Soft Start Diagram

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### OPERATING MODES

The ADP1972 can be programmed to operate as an asynchronous boost or as an asynchronous buck. If the MODE pin is driven low by less than 1.05 V (typical), then the ADP1972 operates in a boost configuration. A boost configuration is ideal for power recycling and discharging in battery charging applications. When the MODE pin is driven high by greater than 1.20 V (typical), the ADP1972 operates in a buck configuration for battery charging. See Figure 19 and Figure 20 for the ADP1972 behavior in each mode. When the ADP1972 is enabled, the internal LDO regulator connected to the VREG pin also powers up. On the rising edge of VREG, the state of the MODE pin is latched, preventing the mode of operation from being changed while the device is enabled. To change between boost and buck modes of operation, shutdown or disable the ADP1972, adjust the MODE pin to change the operating mode, and restart the system.

The operating mode can be changed when the EN pin is driven low, the FAULT pin is driven low, or the ADP1972 is disabled via a TSD event or UVLO condition. On the rising edge of the FAULT control signal, the state of the MODE pin is latched, preventing the mode of operation from being changed while the device is enabled.

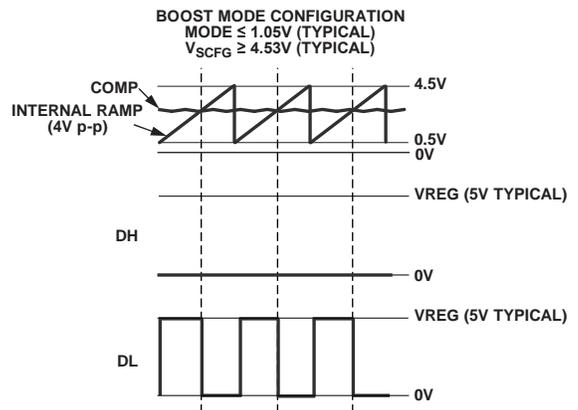


Figure 19. Signal Diagram for Boost Configuration

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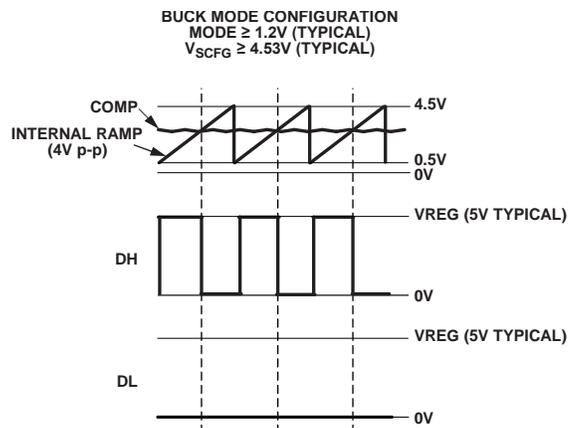


Figure 20. Signal Diagram for Buck Configuration

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**MAXIMUM DUTY CYCLE**

The maximum duty cycle of the [ADP1972](#) can be externally programmed to any value between 0% and 98% via an external resistor on the DMAX pin connected from DMAX to ground. The maximum duty cycle defaults to 98% if DMAX is left floating, is tied to VREG, or is programmed to a value greater than 98%.

**EXTERNAL FAULT SIGNALING**

The [ADP1972](#) is equipped with a FAULT pin that signals the [ADP1972](#) when an external fault condition occurs. The external fault signal stops PWM operation of the system to avoid damage to the application and components. When a voltage less than 1.05 V (typical) is applied to the FAULT pin, the [ADP1972](#) disables. In this state, the DL and DH PWM drive signals are

both driven low to prevent switching of the system dc-to-dc converter, and the soft start is reset. When a voltage greater than 1.20 V (typical) is applied to the FAULT pin, the [ADP1972](#) begins switching. A voltage ranging from 0 V to 60 V can be applied to the FAULT pin of the [ADP1972](#).

**THERMAL SHUTDOWN (TSD)**

The [ADP1972](#) has a TSD protection circuit. The thermal shutdown triggers and disables switching when the junction temperature of the [ADP1972](#) reaches 150°C (typical). While in TSD, the DL and DH signals are driven low and the  $C_{SS}$  capacitor discharges to ground. VREG remains high. When the junction temperature decreases to 135°C (typical), the [ADP1972](#) restarts the application control loop.

## APPLICATIONS INFORMATION

The ADP1972 has many programmable features that are optimized and controlled for a given application. The ADP1972 provides pins for selecting the operating mode, controlling the current limit, selecting an internal or external clock, setting the operating frequency, phase shifting the operating frequency, programming the maximum duty cycle, and adjusting the soft start.

### BUCK OR BOOST SELECTION

To operate the ADP1972 in boost/recycle mode, apply a voltage less than 1.05 V (typical) to the MODE pin. To operate the ADP1972 in buck/discharge mode, drive the MODE pin high, greater than 1.2 V (typical). The state of the MODE pin can only be changed when the ADP1972 is shutdown via the EN pin, or disabled via an external fault condition signaled on the FAULT pin, a TSD event, or a UVLO condition.

### SELECTING $R_S$ TO SET THE CURRENT LIMIT

See Figure 21 for the current-limit block diagram for peak current-limit control. Use using the following equation to set the current limit:

$$I_{PK} \text{ (mA)} = \frac{100 \text{ mV}}{R_S} \quad (1)$$

where:

$I_{PK}$  is the desired peak current-limit in mA.

$R_S$  is the sense resistor used to set the peak current limit in  $\Omega$ .

When the ADP1972 is configured to operate in buck/charge mode, the internal current-limit reference is set to 300 mV (typical). When the ADP1972 is configured to operate in boost/recycle mode, the internal current-limit reference is set to 500 mV (typical). The external resistor,  $R_{CL}$ , is needed to offset the current properly to detect the peak in both buck and boost operation. Set the value of  $R_{CL}$  to 20 k $\Omega$ . In operation, the equation for setting the peak current follows:

For buck/charge mode, it is

$$V_{REF(BUCK)} = (I_{CL}) \times (R_{CL}) - (I_{PK}) \times (R_S) \quad (2)$$

For boost/recycle mode, it is

$$V_{REF(BOOST)} = (I_{CL}) \times (R_{CL}) + (I_{PK}) \times (R_S) \quad (3)$$

where:

$V_{REF(BUCK)}$  = 300 mV, typical.

$V_{REF(BOOST)}$  = 500 mV, typical.

$I_{CL}$  = 20  $\mu$ A, typical.

$R_{CL}$  = 20 k $\Omega$ .

The ADP1972 is designed so that the peak current limit is the same in both the buck mode and boost mode of operation. A 1% or better tolerance for the  $R_{CL}$  and  $R_S$  resistors is recommended.

### ADJUSTING THE OPERATING FREQUENCY

If the SCFG pin is tied to VREG, forcing  $V_{SCFG} \geq 4.53$  V, or if SCFG is left floating and internally tied to VREG, the ADP1972 operates at the frequency set by  $R_{FREQ}$ , and the SYNC pin outputs a clock at the programmed frequency. When  $V_{SCFG} \geq 4.53$  V, the output clock on the SYNC pin can be used as a master clock in applications that require synchronization.

If  $V_{SCFG}$  is  $\leq 0.5$  V, the SYNC pin is configured as an input, and the ADP1972 operates as a slave device. As a slave device, the ADP1972 synchronizes to the external clock applied to the SYNC pin. If the voltage applied to the SCFG pin is  $0.65 \text{ V} < V_{SCFG} < 4.25 \text{ V}$ , and a resistor is connected between SCFG and ground, the SYNC pin is configured as an input, and the ADP1972 synchronizes to a phase shifted version of the external clock applied to the SYNC pin.

Whether operating the ADP1972 as a master or as a slave device,  $R_{FREQ}$  must be carefully selected using the equations in the following sections.

#### Selecting $R_{FREQ}$ for a Master Device

When  $V_{SCFG}$  is  $\geq 4.53$  V, the ADP1972 operates as a master device. When functioning as a master device, the ADP1972 operates at the frequency set by the external  $R_{FREQ}$  resistor connected between FREQ and ground, and the ADP1972 outputs a clock at the programmed frequency on the SYNC pin.

Figure 22 shows the relationship between the programmed switching frequency ( $f_{SET}$ ) and the value of  $R_{FREQ}$ .

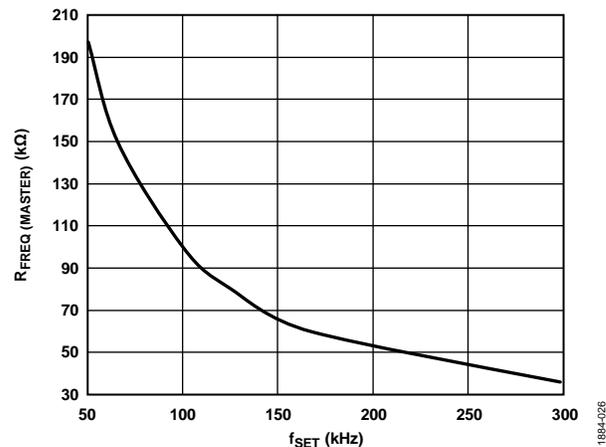


Figure 22.  $R_{FREQ}$  vs. Switching Frequency ( $f_{SET}$ )

Use the following equation to calculate the  $R_{FREQ}$  value for a desired master clock synchronization frequency:

$$R_{FREQ(MASTER)} \text{ (k}\Omega\text{)} = \frac{10^4}{f_{SET} \text{ (kHz)}} \quad (4)$$

where:

$f_{SET}$  is the switching frequency in kHz.

$R_{FREQ(MASTER)}$  is the resistor in k $\Omega$  to set the frequency for master devices.

### Selecting $R_{FREQ}$ for a Slave Device

To configure the ADP1972 as a slave device, drive  $V_{SCFG} < 4.53$  V. When functioning as a slave device, the ADP1972 operates at the frequency of the external clock applied to the SYNC pin. To ensure proper synchronization, select  $R_{FREQ}$  to set the frequency to a value slightly slower than that of the master clock by using the following equation:

$$R_{FREQ(SLAVE)} = 1.11 \times R_{FREQ(MASTER)} \quad (5)$$

where:

$R_{FREQ(MASTER)}$  is the resistor value that corresponds to the frequency of the master clock applied to the SYNC pin.

$R_{FREQ(SLAVE)}$  is the resistor value that appropriately scales the frequency for the slave device, and 1.11 is the  $R_{FREQ}$  slave to master ratio for synchronization.

The frequency of the slave device is set to a frequency slightly lower than that of the master device to allow the digital synchronization loop of the ADP1972 to synchronize to the master clock period. The slave device has approximately a 30% range capability to adjust to match the master clock value. Setting  $R_{FREQ(SLAVE)}$  to  $1.11 \times$  larger than  $R_{FREQ(MASTER)}$  runs the synchronization loop in approximately the center of the adjustment range.

### Programming the External Clock Phase Shift

If a phase shift is not required for slave devices, connect SCFG of each slave device to ground. For devices that require a phase shifted version of the synchronization clock that is applied to the SYNC pin of the slave devices, connect a resistor ( $R_{SCFG}$ ) from SCFG to ground to program the desired phase shift. To determine the  $R_{SCFG}$  for a desired phase shift ( $\phi_{SHIFT}$ ), start by calculating the frequency of the slave clock ( $f_{SLAVE}$ ).

$$f_{SLAVE}(\text{kHz}) = \frac{10^4}{R_{FREQ(SLAVE)}} \quad (6)$$

Next, calculate the period of the slave clock.

$$T_{SLAVE}(\mu\text{s}) = \frac{1}{f_{SLAVE}(\text{kHz})} \times 10^{-3} \quad (7)$$

where:

$T_{SLAVE}$  is the period of the master clock in  $\mu\text{s}$ .

$f_{SLAVE}$  is the frequency of the master clock in kHz.

Next, determine the phase time delay ( $T_{DELAY}$ ) for the desired phase shift ( $\phi_{SHIFT}$ ) using the following equation:

$$T_{DELAY}(\mu\text{s}) = \frac{\phi_{SHIFT} \times T_{SLAVE}(\mu\text{s})}{360} \quad (8)$$

where:

$T_{DELAY}$  is the phase delay in  $\mu\text{s}$ .

$\phi_{SHIFT}$  is the desired phase shift.

Lastly, to calculate the phase delay ( $T_{DELAY}$ ), use the following equation:

$$R_{SCFG}(\text{k}\Omega) = 0.45 \times R_{FREQ(SLAVE)}(\text{k}\Omega) + 50 \times 10^6 \times T_{DELAY}(\mu\text{s}) \quad (9)$$

where:

$R_{SCFG}$  is the corresponding resistor for the desired phase shift in kHz.

When using the phase shift feature, connect a capacitor of 47 pF or greater in parallel with  $R_{SCFG}$ .

Alternatively, the SCFG pin can be controlled with a voltage source. When using an independent voltage source, ensure  $V_{SCFG} \leq V_{REG}$  under all conditions. When the ADP1972 is disabled via the EN pin or UVLO,  $V_{REG} = 0$  V, and the voltage source must adjust accordingly to ensure  $V_{SCFG} \leq V_{REG}$ .

Figure 23 shows the internal voltage ramp of the ADP1972. The voltage ramp has a well controlled 4 V p-p.

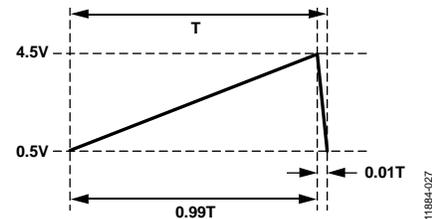


Figure 23. Internal Voltage Ramp

### PROGRAMMING THE MAXIMUM DUTY CYCLE

The ADP1972 is designed with a 98% (typical) internal maximum duty cycle. By connecting a resistor from DMAX to ground, the maximum duty cycle can be programmed at any value from 0% to 98%, using the following equation:

$$D_{MAX}(\%) = \frac{21.5 \times V_{FREQ} \times R_{DMAX}}{R_{FREQ}} - 10.5 \quad (10)$$

where:

$D_{MAX}$  is the programmed maximum duty cycle.

$R_{DMAX}$  is the value of the resistance used to program the maximum duty cycle.

The current source of DMAX is equivalent to the programmed current of the FREQ pin:

$$I_{DMAX} = I_{FREQ} = \frac{V_{FREQ}}{R_{FREQ}} \quad (11)$$

where  $I_{DMAX} = I_{FREQ}$  = the current programmed on the FREQ pin.

The maximum allowable duty cycle of the ADP1972 is 98% (typical). If the resistor on DMAX sets a maximum duty cycle larger than 98%, the ADP1972 defaults to its internal maximum. If the 98% internal maximum duty cycle is sufficient for the application, tie the DMAX pin to VREG or leave it floating.

The  $C_{DMAX}$  capacitor connected from the DMAX pin to GND must be 47 pF or greater.

### ADJUSTING THE SOFT START PERIOD

The ADP1972 has a programmable soft start feature that prevents output voltage overshoot during startup. Refer to Figure 18 for a soft start diagram. Use the following equation to calculate the delay time before switching is enabled ( $t_{REG}$ ):

$$t_{REG} = \frac{0.52}{I_{SS}} \times C_{SS} \quad (12)$$

where  $I_{SS} = 5 \mu\text{A}$ , typical.

A  $C_{SS}$  capacitor is not required for the ADP1972. When the  $C_{SS}$  capacitor is not used, the internal  $5 \mu\text{A}$  (typical) current source immediately pulls the SS pin voltage to VREG. When a  $C_{SS}$  capacitor is not used, there is no soft start control internal to the ADP1972, and the system could produce a large output overshoot and a large peak inductor spike during startup. When a  $C_{SS}$  is not used, ensure that the output overshoot is not large enough to trip the hiccup current limit during startup.

## PCB LAYOUT GUIDELINES

For high efficiency, good regulation, and stability, a well designed PCB layout is required.

Use the following guidelines when designing the PCB (see Figure 16 for the block diagram and Figure 2 for the pin configuration).

- Keep the low effective series resistance (ESR) input supply capacitor for VIN ( $C_{IN}$ ) as close as possible to the VIN and GND pins to minimize noise being injected into the device from board parasitic inductance.
- Keep the low ESR input supply capacitor for VREG ( $C_{VREG}$ ) as close as possible to the VREG and GND pins to minimize noise being injected into the device from board parasitic inductance.
- Place the components for the SCFG, FREQ, DMAX, and SS pins close to the corresponding pins. Tie these components collectively to an AGND plane that makes a Kelvin connection to the GND pin.
- Keep the trace from the COMP pin to the accompanying device (for example, [AD8450](#)) as short as possible. Avoid routing this trace near switching signals and shield the trace if possible.
- Place any trace or components for the SYNC pin away from sensitive analog nodes. When using an external pull-up, it is best to use a local 0.1  $\mu\text{F}$  bypass capacitor from the supply of the pull-up resistor to GND.
- Keep the traces from the DH and DL pins to the external components as short as possible to minimize parasitic inductance and capacitance, which affect the control signal. The DH and DL pins are switching nodes; do not route them near any sensitive analog circuitry.
- Keep high current traces as short and as wide as possible.
- Connect the ground connection of the [ADP1972](#) directly to the ground connection of the current sense,  $R_S$ , resistor.
- Connect CL through a 20 k $\Omega$  resistor directly to  $R_S$ .
- Use a Kelvin connection shown in Figure 24 and Figure 25 from the following:
  - The GND pin to the ground point for  $R_S$
  - The  $\text{GND}_{\text{SENSE}}$  pin to the ground point for  $R_S$
  - The system power ground to the ground point of  $R_S$
 Extra resistance due to PCB routing introduces a voltage difference between the GND pin and the  $\text{GND}_{\text{SENSE}}$  pin. This voltage difference must not exceed  $\pm 0.3\text{ V}$ .

- When building a system with a master and multiple slave devices, the capacitance of the trace attached to the SYNC pin must be minimized.
  - For small systems with only a few slave devices, a resistor connected in series between the master SYNC signal and the slave SYNC input pins limits the capacitance of the trace and reduces the fast ground currents that can inject noise into the master device.
  - For larger applications, the series resistance is not enough to isolate the master SYNC clock. In larger systems, use an external buffer to reduce the capacitance of the trace. The external buffer has the drive capability to support a large number of slave devices.

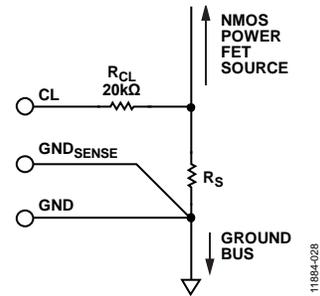


Figure 24. Recommended  $R_S$  Kelvin Ground Connection

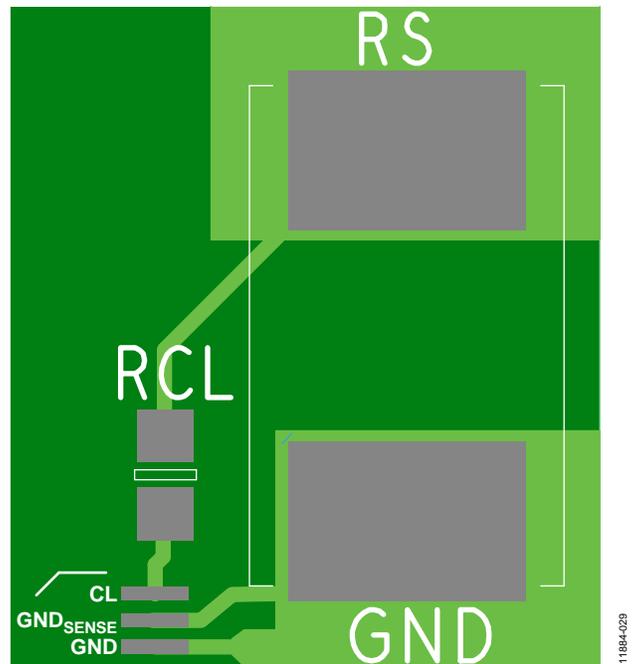
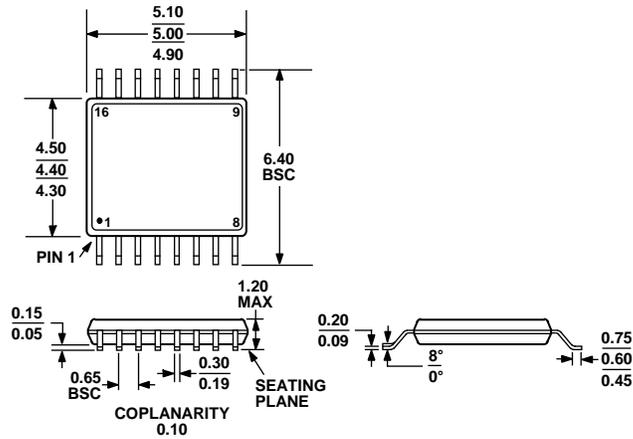


Figure 25. Recommended  $R_S$  Kelvin Ground Connection on PCB Layout

OUTLINE DIMENSIONS



COMPLIANT TO JEDEC STANDARDS MO-153-AB

Figure 26. 16-Lead Thin Shrink Small Outline Package [TSSOP] (RU-16)

Dimensions shown in millimeters

ORDERING GUIDE

Model <sup>1</sup>	Temperature Range	Package Description	Package Option	Ordering Quantity
ADP1972ARUZ-R7	-40°C to +125°C	16-Lead Thin Shrink Small Outline Package [TSSOP], 13" Tape and Reel	RU-16	1,000
ADP1972ARUZ-RL	-40°C to +125°C	16-Lead Thin Shrink Small Outline Package [TSSOP], 7" Tape and Reel	RU-16	2,500
ADP1972-EVALZ		Evaluation Board		

<sup>1</sup> Z = RoHS Compliant Part.

**NOTES**

**NOTES**